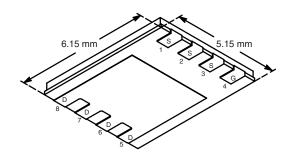


Vishay Siliconix

N-Channel 80 V (D-S) MOSFET

PRODU	CT SUMMARY		
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)
	0.0059 at V _{GS} = 10 V	60	
80	0.0067 at V _{GS} = 7.5 V	60	23 nC
	0.0085 at V _{GS} = 4.5 V	60	

PowerPAK® SO-8



Bottom View

Ordering Information: SiR880DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

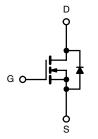
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- · Fixed Telecom
- POL
- DC/DC Converter
- Primary Side Switch



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unle	ss otherwise no	oted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	80	V	
Gate-Source Voltage	V_{GS}	± 20	V		
	T _C = 25 °C		60 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	₋	60 ^a		
Continuous Brain Current (1) = 100 C)	T _A = 25 °C	I _D	23 ^{b, c}		
	T _A = 70 °C		18.4 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	100	^	
Continuous Source-Drain Diode Current	T _C = 25 °C	la	60 ^a		
Continuous Source-Drain Blode Current	T _A = 25 °C	- I _S	5.6 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	35		
Single Pulse Avalanche Energy	L = 0.1 11111	E _{AS}	61	mJ	
	T _C = 25 °C		104	W	
Maximum Power Dissipation	T _C = 70 °C	P _D	66.6		
Maximum i ower Dissipation	T _A = 25 °C	١ ، ١	6.25 ^{b, c}		
	T _A = 70 °C		4.0 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	15	20	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.9	1.2]	

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. See Solder Profile (www.vishay.com/ppg?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.

SiR880DP

Vishay Siliconix



SPECIFICATIONS $T_J = 25 ^{\circ}\text{C}$,			NA'	T	NA		
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static David Resolution Valley	I v	V 0.V I 050A	00		1		
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$ $\Delta V_{GS(th)}/T_J$	I _D = 250 μA		36		mV/°C	
V _{GS(th)} Temperature Coefficient				- 5.8			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V, V _{GS} = 0 V			1	μΑ	
Zoro dato voltago Brain Gunoni		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0049	0.0059	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 7.5 \text{ V}, I_D = 20 \text{ A}$		0.0054	0.0067		
		V _{GS} = 4.5 V, I _D = 15 A		0.0070	0.0085		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 20 A		64		S	
Dynamic ^b				l			
Input Capacitance	C _{iss}			2440			
Output Capacitance	C _{oss}	V _{DS} = 40 V, V _{GS} = 0 V, f = 1 MHz		1525		pF	
Reverse Transfer Capacitance	C _{rss}	ge v de		100			
	133	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		49	74		
Total Gate Charge	Q _g	$V_{DS} = 40 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 20 \text{ A}$		37.2	56	1	
		$V_{DS} = 40 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$		23	35	nC	
Gate-Source Charge	Q _{qs}			7.6			
Gate-Drain Charge	Q _{gd}	105 10 1, 1GS 110 1, 10 = 111		9.2			
Gate Resistance	R _g	f = 1 MHz	0.4	2.1	4.2	Ω	
Turn-On Delay Time	t _{d(on)}	1 - 1 111112	0.1	12	24		
Rise Time	t _r	$V_{DD} = 40 \text{ V, R}_1 = 2 \Omega$		10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A, } V_{GEN} = 10 \text{ V, } R_q = 1 \Omega$		38	70		
Fall Time	t _f	D - ALIV - A		11	22		
Turn-On Delay Time				30	55	ns	
Rise Time	t _{d(on)}	$V_{DD} = 40 \text{ V, R}_{L} = 2 \Omega$		26	50	- - -	
Turn-Off Delay Time	+	$I_D \cong 20 \text{ A, } V_{GEN} = 4.5 \text{ V, } R_q = 1 \Omega$		40	75		
Fall Time	t _{d(off)}	-D019 GEN - 110 1, 11g - 132		12	24		
Drain-Source Body Diode Characteristic	t _f			12			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			60		
	+	10 - 20 0			100	Α	
Pulse Diode Forward Current ^a	I _{SM}	1. – 5 ^		0.75		.,	
Body Diode Voltage	V _{SD}	I _S = 5 A		0.75	1.1	V	
Body Diode Reverse Recovery Time		$\frac{t_{rr}}{Q_{rr}}$ $I_F = 20 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 °C$		56	100	ns	
Body Diode Reverse Recovery Charge				66	120	nC	
Reverse Recovery Fall Time				23		ns	
Reverse Recovery Rise Time	t _b			33			

Notes:

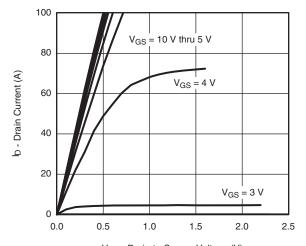
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

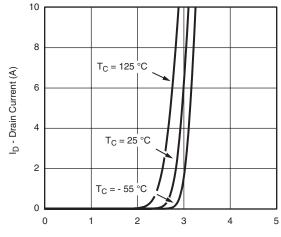


Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

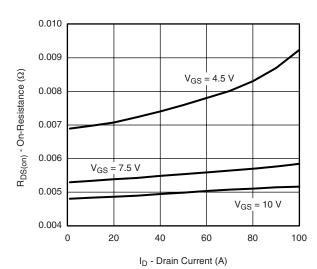


V_{DS} - Drain-to-Source Voltage (V)

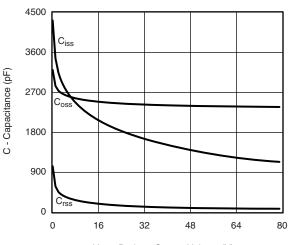


V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**

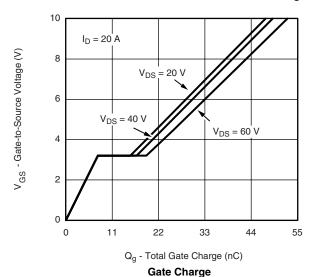
Output Characteristics

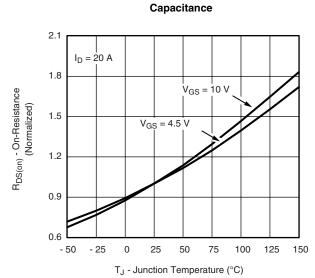


On-Resistance vs. Drain Current and Gate Voltage



 V_{DS} - Drain-to-Source Voltage (V)





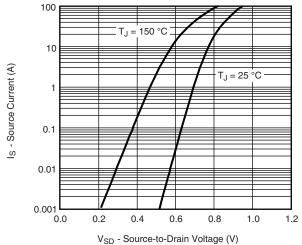
On-Resistance vs. Junction Temperature

SiR880DP

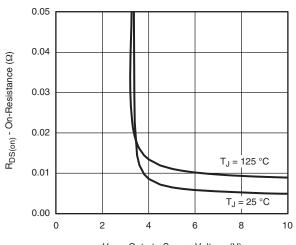
Vishay Siliconix

WISHAY.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

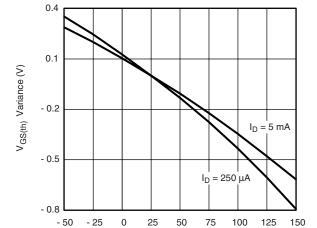


Source-Drain Diode Forward Voltage



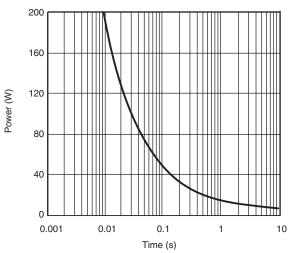
V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

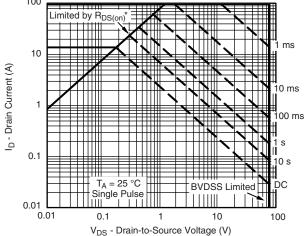


T_J - Temperature (°C)

Threshold Voltage



Single Pulse Power, Junction-to-Ambient



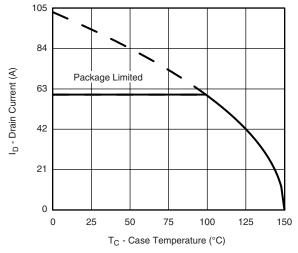
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ isspecified

Safe Operating Area, Junction-to-Ambient

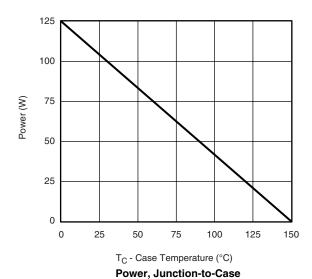


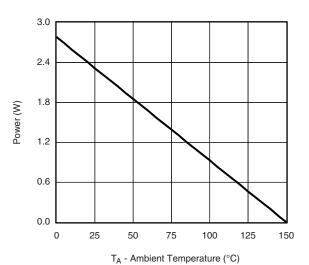
Vishay Siliconix

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





Power, Junction-to-Ambient

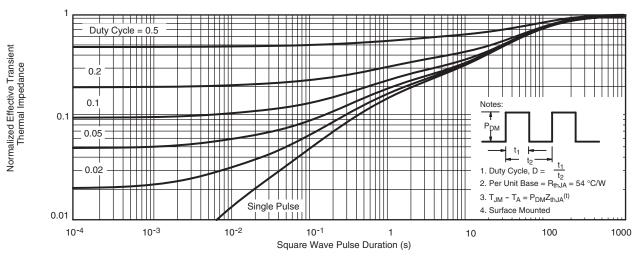
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

SiR880DP

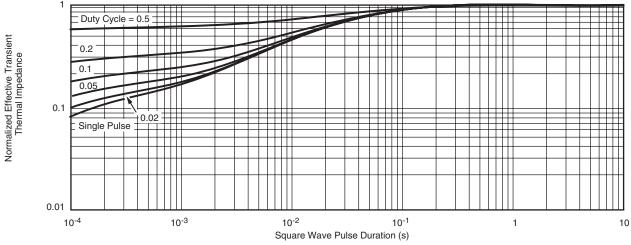
Vishay Siliconix

WISHAY.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?65702.





Vishav

Disclaimer

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.

Revision: 18-Jul-08

www.DataSheet4U.com